

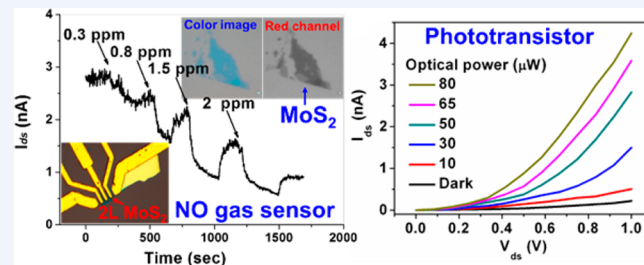
## Preparation and Applications of Mechanically Exfoliated Single-Layer and Multilayer MoS<sub>2</sub> and WSe<sub>2</sub> Nanosheets

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**CONSPECTUS:** Although great progress has been achieved in the study of graphene, the small current ON/OFF ratio in graphene-based field-effect transistors (FETs) limits its application in the fields of conventional transistors or logic circuits for low-power electronic switching. Recently, layered transition metal dichalcogenide (TMD) materials, especially MoS<sub>2</sub>, have attracted increasing attention. In contrast to its bulk material with an indirect band gap, a single-layer (1L) MoS<sub>2</sub> nanosheet is a semiconductor with a direct band gap of ~1.8 eV, which makes it a promising candidate for optoelectronic applications due to the enhancement of photoluminescence and high current ON/OFF ratio.

Compared with TMD nanosheets prepared by chemical vapor deposition and liquid exfoliation, mechanically exfoliated ones possess pristine, clean, and high-quality structures, which are suitable for the fundamental study and potential applications based on their intrinsic thickness-dependent properties. In this Account, we summarize our recent research on the preparation, characterization, and applications of 1L and multilayer MoS<sub>2</sub> and WSe<sub>2</sub> nanosheets produced by mechanical exfoliation. During the preparation of nanosheets, we proposed a simple optical identification method to distinguish 1L and multilayer MoS<sub>2</sub> and WSe<sub>2</sub> nanosheets on a Si substrate coated with 90 and 300 nm SiO<sub>2</sub>. In addition, we used Raman spectroscopy to characterize mechanically exfoliated 1L and multilayer WSe<sub>2</sub> nanosheets. For the first time, a new Raman peak at 308 cm<sup>-1</sup> was observed in the spectra of WSe<sub>2</sub> nanosheets except for the 1L WSe<sub>2</sub> nanosheet. Importantly, we found that the 1L WSe<sub>2</sub> nanosheet is very sensitive to the laser power during characterization. The high power laser-induced local oxidation of WSe<sub>2</sub> nanosheets and single crystals was monitored by Raman spectroscopy and atomic force microscopy (AFM). Hexagonal and monoclinic structured WO<sub>3</sub> thin films were obtained from the local oxidization of single- to triple-layer (1L-3L) and quadruple- to quintuple-layer (4L-5L) WSe<sub>2</sub> nanosheets, respectively. Then, we present Raman characterization of shear and breathing modes of 1L and multilayer MoS<sub>2</sub> and WSe<sub>2</sub> nanosheets in the low frequency range (<50 cm<sup>-1</sup>), which can be used to accurately identify the layer number of nanosheets. Magnetic force microscopy was used to characterize 1L and multilayer MoS<sub>2</sub> nanosheets, and thickness-dependent magnetic response was found. In the last part, we briefly introduce the applications of 1L and multilayer MoS<sub>2</sub> nanosheets in the fields of gas sensors and phototransistors.



### 1. INTRODUCTION

Graphene, a two-dimensional (2D), one-atom-thick, and single-layer (1L) carbon material, has received great interest due to its fascinating properties, such as ultrahigh carrier mobility, good thermal conductivity, and excellent mechanical property.<sup>1,2</sup> However, because of its gapless band structure, the small current ON/OFF ratio in graphene-based field effect transistors (FETs) makes it difficult to use them for conventional transistors or logic circuits for low-power electronic switching at room temperature.<sup>3,4</sup> Many techniques have been tried to modulate the band gap of graphene, such as chemical functionalization of graphene, application of high electric field on graphene, or preparation of graphene nanoribbons. However, the aforementioned modifications might result in the loss of mobility or increase of experimental complexity.<sup>3</sup> Inspired by the great advances of graphene research, layered transition metal dichalcogenide (TMD) materials with band gaps around 1–2 eV have attracted increasing attention in recent years.<sup>3–6</sup>

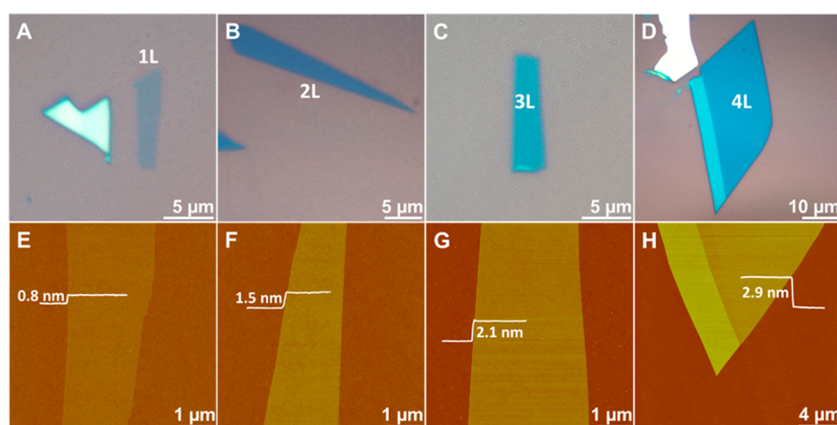
During the last decades, TMDs have been extensively used in the applications of lubrication, catalysis, energy storage, and

photovoltaics.<sup>3,5</sup> When the size of TMDs decreases from three dimensions to two dimensions, interesting layer-dependent properties are found in atomically thin TMD nanosheets compared with their bulk compounds, which are attributed to the quantum confinement and surface effects.<sup>3–12</sup> For example, some bulk TMDs are semiconductors with indirect band gaps, while their 1L nanosheets are semiconductors with direct band gaps, resulting in the dramatic properties such as the enhancement of photoluminescence.<sup>7,13,14</sup> Valley polarization was also found in the 1L MoS<sub>2</sub> nanosheet but not in the double-layer (2L) MoS<sub>2</sub> nanosheet.<sup>15,16</sup>

Very recently, atomically thin 2D TMD nanosheets have exhibited extensive applications in transistors, sensors, memory devices, and optoelectronic devices.<sup>13,17–35</sup> Similar to graphite, the MoS<sub>2</sub> bulk crystal is naturally abundant. Therefore, a mechanical exfoliation method has been used to prepare atomically thin MoS<sub>2</sub> nanosheets for various applica-

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**Figure 1.** Mechanically exfoliated single- and few-layer MoS<sub>2</sub> nanosheets on 300 nm SiO<sub>2</sub>/Si. Optical microscopy (A–D) and AFM (E–H) images of single-layer (1L, thickness 0.8 nm; A and E), double-layer (2L, thickness 1.5 nm; B and F), triple-layer (3L, thickness 2.1 nm; C and G), and quadruple-layer (4L, thickness 2.9 nm; D and H) MoS<sub>2</sub> nanosheets. Reprinted with permission from ref 18. Copyright 2012 Wiley-VCH Verlag GmbH & Co.

tions.<sup>5,7,8,10,12–21,36,37</sup> Among the other TMD crystals, WSe<sub>2</sub> is one of the most widely studied materials due to the easy synthesis and tunable doping behavior of its bulk crystal. The study of WSe<sub>2</sub> bulk crystal is mainly focused on the photovoltaic application in the conversion of solar energy into electricity and photoelectrochemical hydrogen production.<sup>38,39</sup> However, only a few of studies focus on the characterization and applications of mechanically exfoliated single-layer to multilayer WSe<sub>2</sub> nanosheets.<sup>8,40–44</sup>

Many methods have been reported to prepare the atomically thin MoS<sub>2</sub> and WSe<sub>2</sub> nanosheets, including mechanical exfoliation,<sup>5,8,13–18,20,36,40,41–43</sup> chemical exfoliation,<sup>11,35</sup> chemical vapor deposition,<sup>45</sup> and sonication.<sup>46</sup> Although its scale-up is limited, the mechanical exfoliation is still a powerful method to fabricate atomically thin 2D layered nanosheets for investigation of their intrinsic thickness-dependent properties. In this Account, we focus on the preparation, characterization, and applications of the mechanically exfoliated MoS<sub>2</sub> and WSe<sub>2</sub> nanosheets.

## 2. PREPARATION AND CHARACTERIZATION OF SINGLE-LAYER AND MULTILAYER MoS<sub>2</sub> AND WSe<sub>2</sub> NANOSHEETS

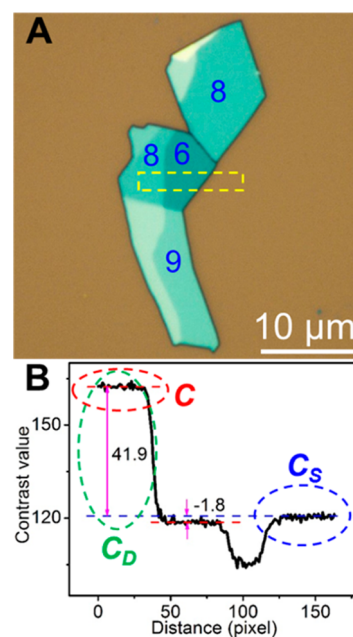
### 2.1. Preparation of Single-Layer and Multilayer MoS<sub>2</sub> and WSe<sub>2</sub> Nanosheets by Mechanical Exfoliation

To date, mechanical exfoliation is the most efficient way to produce the cleanest, highly crystalline and atomically thin nanosheets of layered materials. In a typical mechanical exfoliation process, appropriate thin TMD crystals are first peeled off from their bulk crystals by using adhesive Scotch tape. These freshly cleaved thin crystals on Scotch tape are brought into contact with a target substrate and rubbed by using tools such as plastic tweezers to further cleave them. After the Scotch tape is removed, 1L and multilayer TMD nanosheets are left on the substrate. As shown in Figure 1, 1L to quadruple-layer (4L) MoS<sub>2</sub> nanosheets with clean surfaces were deposited on Si substrates with 300 nm SiO<sub>2</sub> coating layer (referred to as 300 nm SiO<sub>2</sub>/Si).<sup>18</sup> AFM measurement indicates that the heights of 1L–4L MoS<sub>2</sub> nanosheets are 0.8, 1.5, 2.1, and 2.9 nm, respectively.

### 2.2. Optical Identification of Single-Layer and Multilayer MoS<sub>2</sub> Nanosheets

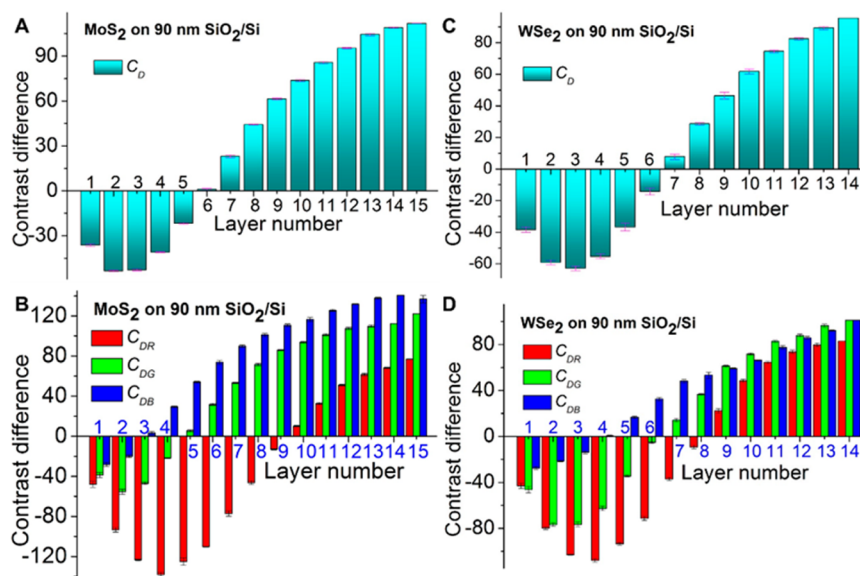
By use of the mechanical exfoliation method, not only 1L and multilayer MoS<sub>2</sub> nanosheets but also a large quantity of thicker and bulk-like MoS<sub>2</sub> flakes are left on the substrate. Therefore,

how to locate and identify the 1L and multilayer MoS<sub>2</sub> nanosheets in a rapid and accurate way is the first step prior to the fundamental research and practical applications. Recently, we have developed a simple, rapid, and reliable optical method to identify the single- to quindecuple-layer (1L–15L) 2D nanosheets, such as graphene, MoS<sub>2</sub>, WSe<sub>2</sub>, and TaS<sub>2</sub>, on 90 or 300 nm SiO<sub>2</sub>/Si.<sup>47</sup> Taking MoS<sub>2</sub> nanosheet on 90 nm SiO<sub>2</sub>/Si as an example (Figure 2A), the optical contrast of the MoS<sub>2</sub> nanosheet

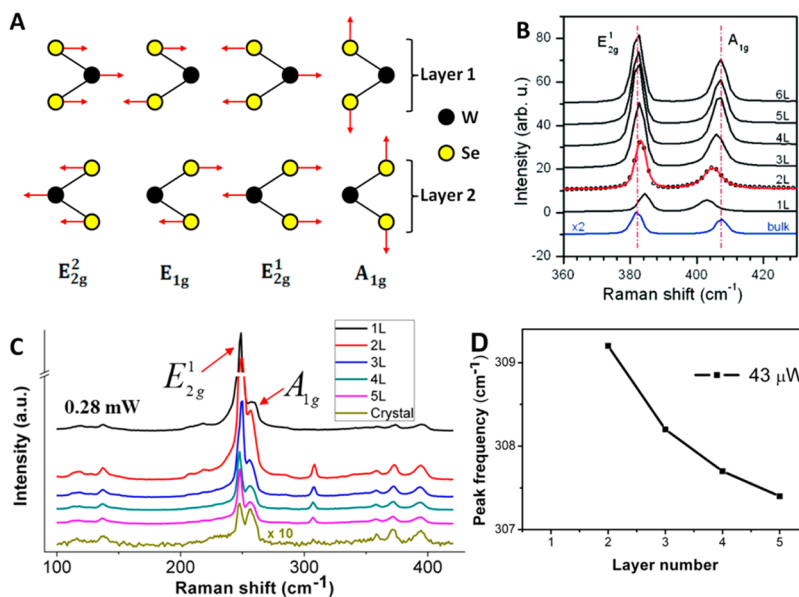


**Figure 2.** (A) Color optical image of a MoS<sub>2</sub> flake deposited on 90 nm SiO<sub>2</sub>/Si. The digits indicate the layer numbers of MoS<sub>2</sub> nanosheets. (B) Contrast profile of the dashed rectangle shown in panel A. Reprinted with permission from ref 47. Copyright 2013 American Chemical Society.

and substrate are defined as  $C$  and  $C_S$  (Figure 2B), respectively, which were measured from its color optical image by using ImageJ.<sup>48</sup> The contrast difference between MoS<sub>2</sub> and substrate is defined as  $C_D$  (Figure 2B). By measuring the  $C_D$  values of MoS<sub>2</sub> nanosheets with different layer numbers, we generated a standard chart of  $C_D$  values vs layer number (Figure 3A), which can be



**Figure 3.** Plot of  $C_D$  values (A, C) and  $C_{DR}$ ,  $C_{DG}$ , and  $C_{DB}$  values (B, D) of 1L–15L MoS<sub>2</sub> (A, B) and 1L–14L WSe<sub>2</sub> (C, D) nanosheets on 90 nm SiO<sub>2</sub>/Si. Reprinted with permission from ref 47. Copyright 2013 American Chemical Society.



**Figure 4.** (A) Atomic displacements of the four Raman-active modes in the unit cell of the bulk WSe<sub>2</sub> crystal. (B) Raman spectra of 1L–6L MoS<sub>2</sub> nanosheets and bulk crystal. (C) Raman spectra of 1L–5L WSe<sub>2</sub> nanosheets and bulk crystal at laser excitation power of 0.28 mW. (D) Peak frequencies of the Raman peak near 308 cm<sup>-1</sup> as a function of layer number of WSe<sub>2</sub> at laser excitation power of 43 μW. Reprinted with permission from refs 40 and 49. Copyright 2012 Wiley-VCH Verlag GmbH & Co and 2010 American Chemical Society.

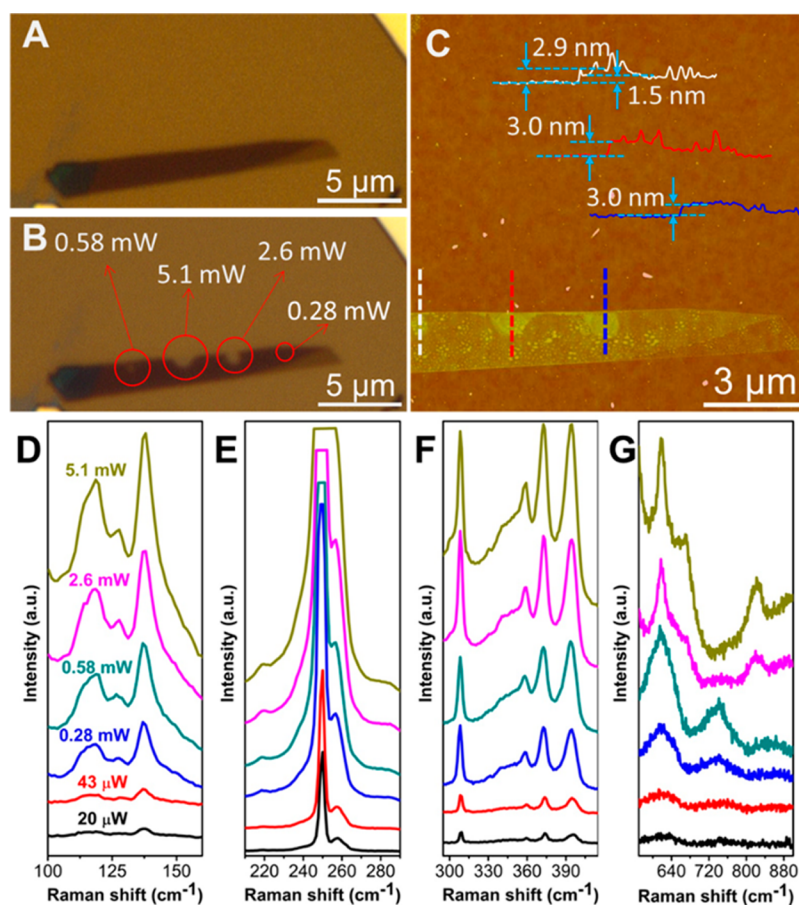
readily used to determine the thickness of MoS<sub>2</sub> nanosheets on 90 nm SiO<sub>2</sub>/Si.

However, the  $C_D$  values of 1L and 4L MoS<sub>2</sub> nanosheets as well as 2L and 3L MoS<sub>2</sub> nanosheets on 90 nm SiO<sub>2</sub> substrate are indistinguishable (Figure 3A). In order to reliably distinguish MoS<sub>2</sub> nanosheets on 90 nm SiO<sub>2</sub>/Si, the color optical image of the MoS<sub>2</sub> nanosheet is split into the grayscale red (R), green (G), and blue (B) channel images using the ImageJ.<sup>48</sup> The contrast difference between the MoS<sub>2</sub> nanosheet and substrate in R, G, or B channel is defined as  $C_{DR}$ ,  $C_{DG}$  or  $C_{DB}$ , respectively. By measuring the  $C_{DR}$ ,  $C_{DG}$  and  $C_{DB}$  values, 1L–15L MoS<sub>2</sub> nanosheets on 90 nm SiO<sub>2</sub>/Si can be reliably identified (Figure 3B). Similarly, 1L–14L WSe<sub>2</sub> nanosheets on 90 nm SiO<sub>2</sub>/Si can also be reliably identified by measuring the  $C_D$ ,  $C_{DR}$ ,  $C_{DG}$ , and  $C_{DB}$

values (Figure 3C,D). In addition, 1L–15L MoS<sub>2</sub> and 1L–14L WSe<sub>2</sub> nanosheets on 300 nm SiO<sub>2</sub>/Si can also be identified by using this optical method.<sup>47</sup>

### 2.3. Raman Characterization of Single-Layer and Multilayer MoS<sub>2</sub> and WSe<sub>2</sub> Nanosheets

Raman spectroscopy has been widely used to characterize structural and electronic properties of 2D layered nanomaterials. It is also an effective technique for the rapid identification and characterization of MoS<sub>2</sub> and WSe<sub>2</sub> nanosheets.<sup>8,40,44,49,50</sup> As shown in Figure 4A, MoS<sub>2</sub> and WSe<sub>2</sub> bulk crystals usually have four Raman active modes,  $E_{2g}^2$ ,  $E_{1g}$ ,  $E_{2g}^1$  and  $A_{1g}$ .<sup>40</sup> Due to the selection rules in the backscattering geometry, the  $E_{1g}$  mode is hardly observed. In addition, the low-energy  $E_{2g}^2$  mode is difficult to detect with the common commercial instrument because of



**Figure 5.** Optical images of 2L WSe<sub>2</sub> nanosheets before (A) and after (B) Raman characterization. The red circles shown in panel B indicate spots where the Raman spectra were recorded. (C) The corresponding AFM image of panel B. Inset, height profiles of spots. (D–G) Raman spectra of 2L WSe<sub>2</sub> nanosheets in the range of (D) 100–160 cm<sup>-1</sup>, (E) 210–290 cm<sup>-1</sup>, (F) 295–415 cm<sup>-1</sup>, and (G) 570–900 cm<sup>-1</sup> with laser excitation power increased from 20 μW to 5.1 mW. Reprinted with permission from ref 40. Copyright 2013 Wiley-VCH Verlag GmbH & Co.

the limited rejection of the Rayleigh scattering.<sup>8,49</sup> Therefore, a special notch filter is necessary to detect the  $E_{2g}^2$  mode.<sup>8</sup> The  $E_{2g}^1$  and  $A_{1g}$  modes of 1L MoS<sub>2</sub> nanosheets are located at  $\sim 384$  and  $403$  cm<sup>-1</sup>, respectively.<sup>18,36,49</sup> Red shift of the  $E_{2g}^1$  mode and blue shift of the  $A_{1g}$  mode were observed with increase of the layer number of MoS<sub>2</sub> nanosheets from 1L–4L (Figure 4B).<sup>49</sup> There is no obvious difference in Raman spectra between MoS<sub>2</sub> nanosheets thicker than 4L and bulk crystal.

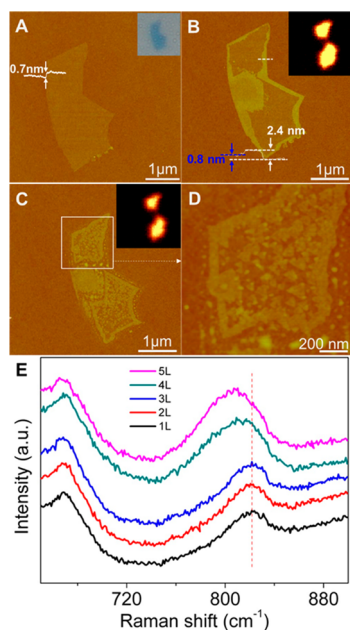
In contrast to MoS<sub>2</sub>, there are some second order and combinational modes in addition to  $E_{2g}^1$  and  $A_{1g}$  modes in the Raman spectrum of WSe<sub>2</sub> bulk crystal (Figure 4C).<sup>40</sup> Two strong peaks around  $250$  cm<sup>-1</sup> are assigned to  $E_{2g}^1$  and  $A_{1g}$  modes, respectively. Interestingly, the peak at  $308$  cm<sup>-1</sup> is absent in 1L WSe<sub>2</sub> nanosheet and becomes Raman active in 2L and thicker WSe<sub>2</sub> nanosheets,<sup>8,40</sup> which can be used to quickly identify 1L WSe<sub>2</sub> nanosheet. The Raman peaks at  $308$  cm<sup>-1</sup> red shift with the increasing layer number (Figure 4D), which might reflect the presence of additional interlayer interactions.

It is well-known that laser-induced local heating will affect the Raman characterization of materials. Although MoS<sub>2</sub> bulk crystal is stable even when exposed to a laser power of  $6.3$  mW, a laser power of  $10$  mW can induce thinning of multilayer MoS<sub>2</sub> down to 1L.<sup>37</sup> However, we found that WSe<sub>2</sub> bulk crystal and nanosheets are very sensitive to laser-induced local heating.<sup>40</sup>

WSe<sub>2</sub> bulk crystal undergoes laser-assisted oxidation when exposed to a laser power of  $2.6$  mW.<sup>40</sup> The oxidation of 2L WSe<sub>2</sub> nanosheets occurs when they are exposed to a laser power

of  $0.58$  mW (Figure 5A, B), which can be clearly observed by optical microscopy (Figure 5B) and AFM measurements (Figure 5C). As the laser power increased from  $20$  μW to  $0.28$  mW, the intensities of Raman peaks kept increasing but no notable shift was observed (Figure 5D–F). When the laser power was increased from  $0.58$  to  $5.1$  mW, a new peak appearing at  $822$  cm<sup>-1</sup> was observed (Figure 5G), which is attributed to the formation of hexagonal WO<sub>3</sub>.<sup>40,51</sup>

The evolution of 1L WSe<sub>2</sub> nanosheets to hexagonal WO<sub>3</sub> is further monitored by the Raman and AFM measurements. As shown in Figure 6A, the thickness of a 1L WSe<sub>2</sub> nanosheet is  $\sim 0.7$  nm. After the nanosheet is exposed to a  $488$  nm laser with an excitation power of  $0.7$  mW for Raman mapping, the laser-induced oxidation starts from the edge of the 1L WSe<sub>2</sub> nanosheet, indicating that the edge is highly defective. As shown in Figure 6B, the height of edges increased to  $\sim 2.4$  nm after oxidation, which is consistent with the height of a triangular WO<sub>3</sub> film formed by electrochemical oxidation of WSe<sub>2</sub> bulk crystal.<sup>52</sup> The formed WO<sub>3</sub> film shows structures with  $60^\circ$  or  $120^\circ$  angles, indicating the formation of hexagonal WO<sub>3</sub>, which is consistent with the Raman measurement. The central area of the 1L WSe<sub>2</sub> nanosheet remains intact after the first round of Raman mapping (Figure 6B), which indicates the smooth and defect-free vdW face of the mechanically exfoliated WSe<sub>2</sub> nanosheet. It has been reported that a defect-free van der Waals (vdW) face of WSe<sub>2</sub> is inert to the oxidation.<sup>53</sup> More structures with angles of  $60^\circ$  or  $120^\circ$  and height of  $2.4$  nm



**Figure 6.** AFM images of 1L WSe<sub>2</sub> nanosheet before (A) and after the first (B) and second (C,D) rounds of oxidation by a laser with high excitation power of 0.7 mW. Inset in panel A is the optical image. Bottom inset in panel B shows the height profile of the white dashed line. Top right insets in panels B and C are the corresponding Raman mapping images. (D) AFM image of the white square in panel C. (E) Raman spectra of 1L–5L WSe<sub>2</sub> nanosheets oxidized by a laser with high excitation power in the range of 650–900 cm<sup>-1</sup>. Reprinted with permission from ref 40. Copyright 2013 Wiley-VCH Verlag GmbH & Co.

appeared in the WSe<sub>2</sub> nanosheet surface after the second round of Raman mapping (Figure 6C,D), further confirming the formation of a hexagonal WO<sub>3</sub> film by laser-induced oxidation. Moreover, the oxidation of 2L–5L WSe<sub>2</sub> nanosheets was also studied using the Raman and AFM measurements. Similar to 1L WSe<sub>2</sub>, hexagonal structured WO<sub>3</sub> films were found on 2L and 3L WSe<sub>2</sub> nanosheets after they were exposed to the laser with high power in ambient conditions, while monoclinic structured WO<sub>3</sub> films were found on 4L and 5L WSe<sub>2</sub> nanosheets.<sup>40</sup> The oxidation of 1L–5L WSe<sub>2</sub> nanosheets was also confirmed by Raman characterization. As shown in Figure 6E, the Raman peaks appeared at 822, 822, 822, 811, and 807 cm<sup>-1</sup> for 1L, 2L, 3L, 4L, and 5L WSe<sub>2</sub> nanosheets, respectively, after they were exposed to the laser with high power in ambient conditions. The peak around 820 cm<sup>-1</sup> is attributed to the hexagonal WO<sub>3</sub>, while the peak around 810 cm<sup>-1</sup> is attributed to the monoclinic WO<sub>3</sub>.<sup>40,51</sup>

#### 2.4. Low-Frequency Raman Characterization of Single-Layer and Multilayer MoS<sub>2</sub> and WSe<sub>2</sub> Nanosheets

In the low-frequency Raman spectrum range (<50 cm<sup>-1</sup>), we have observed two thickness-dependent modes in multilayer MoS<sub>2</sub> and WSe<sub>2</sub> nanosheets, that is, shear ( $E_{2g}^2$ ) and breathing ( $B_{2g}^2$ ) modes.<sup>8</sup> The shear mode originates from in-plane oscillation of adjacent layers, which is parallel to the layer plane and also observed in bulk MoS<sub>2</sub>, while the optically inactive breathing mode comes from the interlayer out-of-plane oscillation, which is perpendicular to the layer plane and not observed in bulk MoS<sub>2</sub>.

As shown in Figure 7A, no rigid-layer vibration is observed in 1L MoS<sub>2</sub>, which confirms the shear and breathing modes as interlayer vibrational modes. The strongest peak with a narrow

bandwidth, that is, the  $E_{2g}^2$  mode (labeled as S1), undergoes a blue shift from 2L (~22 cm<sup>-1</sup>) to 12L (~32 cm<sup>-1</sup>) MoS<sub>2</sub> nanosheets.<sup>8</sup> There is almost no shift of the S1 peak from 12L MoS<sub>2</sub> nanosheet to bulk crystal, while the second strongest peak with a broad bandwidth, that is,  $B_{2g}^2$  mode (labeled as B1), undergoes a red shift from 2L (~40 cm<sup>-1</sup>) to 9L (~10 cm<sup>-1</sup>) MoS<sub>2</sub> nanosheets. The B1 peak is further red-shifted to ~5 cm<sup>-1</sup> as the thickness of MoS<sub>2</sub> nanosheet increases to 19L,<sup>54</sup> which is out of the detection limit of our instrument. Moreover, two weak peaks labeled as S2 (shear mode) and B2 (breathing mode) are also observed for MoS<sub>2</sub> nanosheets thicker than 4L and 3L, respectively. Similarly, S2 peak undergoes a blue shift, while B2 peak undergoes a red shift with increased thickness (Figure 7A,B).

In terms of WSe<sub>2</sub>, the same Raman-active modes with similar trends of evolution versus thickness is observed (Figure 7C,D), except that the frequencies of Raman modes are lower in WSe<sub>2</sub> compared with those of MoS<sub>2</sub>. In addition, the B2 peak in WSe<sub>2</sub> is much stronger than that of MoS<sub>2</sub>. As shown in Figure 7B,D, the breathing modes (B1 and B2 peaks) are strongly suppressed in the  $\bar{z}(xy)z$  polarization, which is in agreement with the Raman selection rules for breathing modes.<sup>8,54</sup> Importantly, the aforementioned thickness-dependent Raman modes in low frequency range can be used for the accurate thickness identification of MoS<sub>2</sub> and WSe<sub>2</sub> nanosheets.

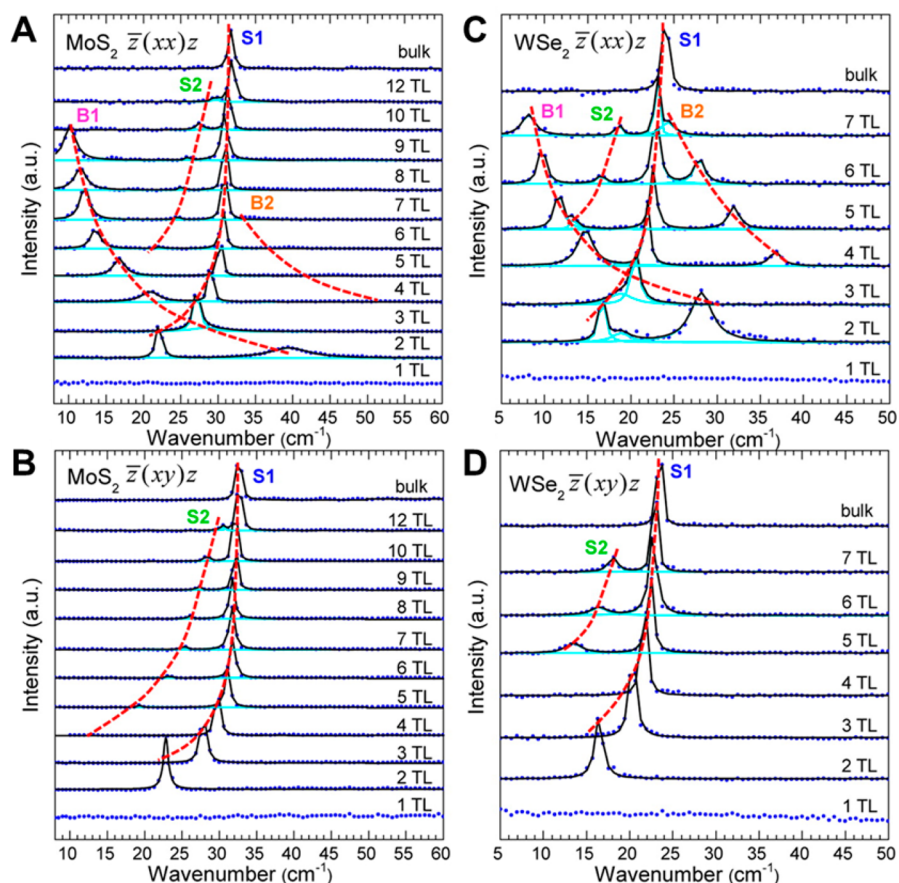
The atomically thin 2D nanosheets usually show novel physical properties compared with their bulk materials.<sup>3–12</sup> The MoS<sub>2</sub> crystal is nonmagnetic. However, it has been reported that the MoS<sub>2</sub> nanosheet with typical edge dimension of ~100 nm has shown weak magnetism, which might be attributed to the existence of the zigzag edges in the ferromagnetic ground state.<sup>55</sup> In our magnetic force microscopy (MFM) study, we found that the magnetic response of MoS<sub>2</sub> nanosheets is thickness-dependent, that is, the increase of magnetic signal has been observed in MoS<sub>2</sub> thin flake as its thickness decreased.<sup>12</sup>

### 3. APPLICATIONS OF SINGLE-LAYER AND MULTILAYER MoS<sub>2</sub> NANOSHEETS BASED DEVICES

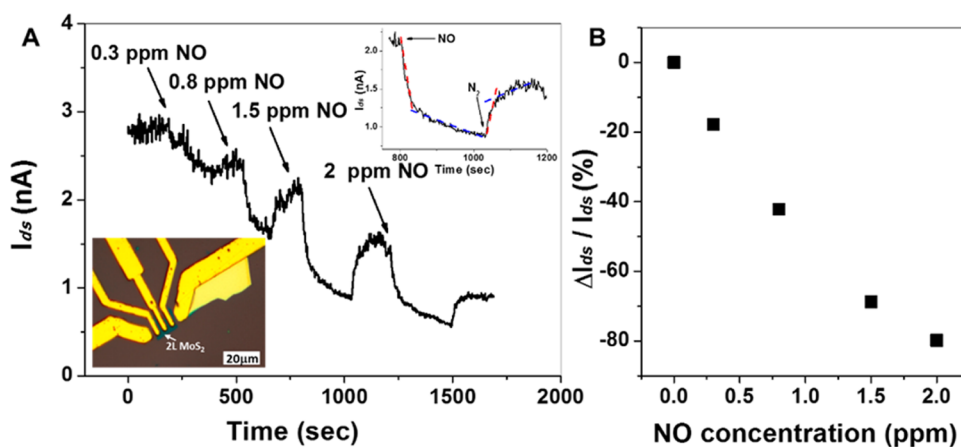
#### 3.1. Gas Sensors

Compared with a 1D semiconductor, the 2D configuration of graphene nanosheets enables better adsorption of gas molecules and thus leads to lower electrical noise and better detection limit. As the semiconducting analogue of graphene, the MoS<sub>2</sub> nanosheet is expected to be a potential candidate for gas sensing applications.

As a proof of concept, MoS<sub>2</sub> field-effect transistor (FET) devices were fabricated with mechanically exfoliated 1L–4L MoS<sub>2</sub> nanosheets as channels and used to detect NO gas at room temperature.<sup>18</sup> MoS<sub>2</sub> FETs fabricated with 2L–4L MoS<sub>2</sub> nanosheets exhibited better performance compared with the 1L MoS<sub>2</sub> nanosheet-based device, which showed rapid but unstable response. Figure 8A shows the current response of a 2L MoS<sub>2</sub> nanosheet-based FET device upon exposure to NO with concentrations ranging from 0.3 to 2 ppm. When the device was exposed to NO gas, the current dropped quickly for the first stage (~30 s) and then continuously decreased for more than 2 min until the saturation of NO adsorption was achieved (top right inset in Figure 8A). Due to the strong adsorption of NO on the MoS<sub>2</sub> surface, complete desorption of adsorbed NO molecules was very slow. A plot of percent change in the current of 2L MoS<sub>2</sub> FET as a function of NO concentration is shown in Figure 8B. The detection limit of 2L MoS<sub>2</sub> FET was 0.8 ppm NO, at which the signal-to-noise ratio is approximately 3. Our results indicate



**Figure 7.** The shear and breathing modes evolutions as a function of layer number of MoS<sub>2</sub> and WSe<sub>2</sub> nanosheets in low-frequency Raman spectra. (A, B) Low-frequency Raman spectra of 1L–12L MoS<sub>2</sub> nanosheets measured using the  $\bar{z}(xx)z$  polarization configuration (A) and the  $\bar{z}(xy)z$  polarization configuration (B), respectively. (C, D) Low-frequency Raman spectra of 1L–7L WSe<sub>2</sub> nanosheets measured under the  $\bar{z}(xx)z$  polarization configuration (C) and  $\bar{z}(xy)z$  polarization configuration (D), respectively. The blue dots are experimental data points, while the black solid curves are Lorentzian fittings to the data. S1–S2 and B1–B2 represent the shear and breathing modes, respectively. Reprinted with permission from ref 8. Copyright 2013 American Chemical Society.



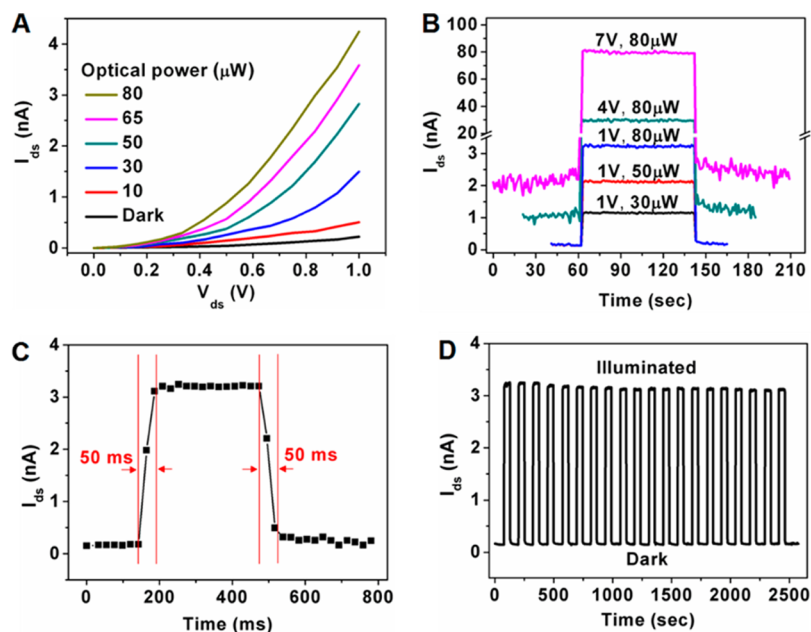
**Figure 8.** NO gas sensor based on a 2L MoS<sub>2</sub> FET device. (A) Real-time current response after exposure of the 2L MoS<sub>2</sub> FET to NO gas with increasing concentration. Bottom inset, optical image of the FET device. Top right inset, a typical adsorption and desorption process of NO with rapid (red dashed lines) and slow steps (blue dashed lines). (B) Plot of percentage change in current vs concentration of NO gas. Reprinted with permission from ref 18. Copyright 2012 Wiley-VCH Verlag GmbH & Co.

that the mechanically exfoliated multilayer MoS<sub>2</sub> nanosheets are promising channel materials for potential gas sensors.

### 3.2. Phototransistors

Bulk MoS<sub>2</sub> is a semiconductor with an indirect band gap of 1.3 eV, while a transition from indirect to direct band gap is observed

when the thickness of MoS<sub>2</sub> is single-layer.<sup>7</sup> This unique characteristic of 1L MoS<sub>2</sub> nanosheet is expected to result in outstanding optoelectronic properties, which inspires the research on its related optoelectronic device applications. Our group first developed a highly photoresponsive transistor based



**Figure 9.** Electrical characteristics of a single-layer MoS<sub>2</sub> nanosheet based phototransistor. (A) Typical output characteristics of phototransistor at different illuminating optical power (10–80 μW) at  $V_g = 0$  V. (B) Photoswitching characteristics of a single-layer MoS<sub>2</sub> phototransistor at different optical power ( $P_{\text{light}}$ ) and drain voltage ( $V_{\text{ds}}$ ). (C) Photoswitching rate and (D) stability test of photoswitching behavior of a single-layer MoS<sub>2</sub> phototransistor at  $V_{\text{ds}} = 1$  V,  $P_{\text{light}} = 80$  μW. Reprinted with permission from ref 13. Copyright 2012 American Chemical Society.

on 1L MoS<sub>2</sub> with 300 nm SiO<sub>2</sub> as the bottom dielectric layer on the Si substrate.<sup>13</sup> As shown in Figure 9A, the photocurrent of the 1L MoS<sub>2</sub> phototransistor increases with the incident optical power within the whole range of applied drain voltage (0–1 V). Figure 9B further indicates the dependence of photocurrent on the optical power and drain voltage, which demonstrates that the photocurrent from the 1L MoS<sub>2</sub> phototransistor can be well controlled by the illuminated optical power and applied drain voltage. Prompt photocurrent generation and annihilation (also called photoswitching) behavior is observed and can be completely switched between ON and OFF states within ca. 50 ms by manipulating the incident light (Figure 9C). Moreover, the 1L MoS<sub>2</sub> phototransistor exhibits quite stable characteristics. As shown in Figure 9D, applying multiple periodic illumination–dark cycles on the device can consistently switch it ON and OFF. Impressively, with constant incident optical power of 80 μW and drain voltage at 1 V, the photoresponsivity of our 1L MoS<sub>2</sub> phototransistor reaches 7.5 mA/W at the applied gate voltage of ~50 V. It is higher than that of a graphene-based device, which is ~1 mA/W at the applied gate voltage of 60 V.<sup>56</sup>

Several following studies on phototransistors based on mechanically exfoliated MoS<sub>2</sub> nanosheets were also reported from other research groups. By using ITO as top gate electrode and 50 nm thick Al<sub>2</sub>O<sub>3</sub> on top of MoS<sub>2</sub> as the dielectric layer, Lee et al. fabricated transparent top-gate phototransistors based on mechanically exfoliated 1L–3L MoS<sub>2</sub> nanosheets.<sup>20</sup> They found that 1L and 2L MoS<sub>2</sub> nanosheets with band gaps of 1.8 and 1.65 eV, respectively, exhibit efficient detection for green light, while 3L MoS<sub>2</sub> with a band gap of 1.35 eV is more sensitive for red light detection. The average photoresponsivity of these devices can reach ~100 mA/W under gate voltages from –7 to –10 V. A similar photoresponsivity was also obtained from a bottom-gate phototransistor based on mechanically exfoliated multilayer MoS<sub>2</sub>, where atomic-layer-deposited (ALD) 50 nm thick Al<sub>2</sub>O<sub>3</sub> was used as the bottom dielectric layer and the applied gate voltage was –3 V.<sup>57</sup> In the aforementioned reports, applying

negative gate voltage brings the advantages of low dark current for the phototransistor, which lowers heat generation during the device operation.<sup>20,57</sup> Very recently, by carefully removing a thin (<5 nm) surface layer of the SiO<sub>2</sub> dielectric layer followed by the plasma treatment, the photoresponsivity of a bottom-gate phototransistor based on a single-layer MoS<sub>2</sub> nanosheet reached a new record of 880 A/W at gate voltage of –70 V, due to the improved mobility of the device.<sup>14</sup>

#### 4. CONCLUSIONS AND OUTLOOK

In this Account, we summarized the preparation, characterization, and applications of single-layer and multilayer MoS<sub>2</sub> and WSe<sub>2</sub> nanosheets prepared by the mechanical exfoliation method. The obtained MoS<sub>2</sub> and WSe<sub>2</sub> nanosheets are suitable for fundamental study of their intrinsic thickness-dependent properties, such as band gap, mobility, and vibrational mode.

Some challenges still remain in the application of the mechanically exfoliated nanosheets. First, the mechanical exfoliation method needs large sized TMD bulk crystals in order to prepare nanosheets with suitable size for characterization and device fabrication. However, many TMD bulk crystals need to be synthesized by the chemical vapor transport (CVT) method, which is time-consuming and expensive. Second, mechanical exfoliation usually produces nonuniform flakes. Therefore, rapid determination of location and layer number of mechanically exfoliated nanosheets is very important.

Although many efforts are focused on mechanically exfoliated MoS<sub>2</sub> nanosheets, a few studies have been reported on mechanically exfoliated WSe<sub>2</sub> nanosheets. Interestingly, the pristine p-type WSe<sub>2</sub> nanosheet can be simply tuned to n-type by selecting a proper contact metal or doping the contacts accordingly.<sup>42,43</sup> We believe the fundamental study and potential applications of mechanically exfoliated 1L and multilayer MoS<sub>2</sub> and WSe<sub>2</sub> nanosheets in the fields of electronic devices, optoelectronics, integrated circuits, and sensors might open up an avenue for other TMD nanosheets.

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## Notes

The authors declare no competing financial interest.

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